

INFORMATION DISCLOSURE CITATION IN AN APPLICATION

ATTY. DOCKET NO.
065933-0065

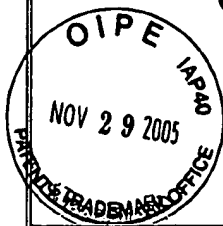
SERIAL NO.
10/754,926

APPLICANT
Yukihiro NOGUCHI, et al.

FILING DATE
January 12, 2004

GROUP
2819

(PTO-1449)



U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		US			
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FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	CITE NO.	Foreign Patent Document Country Code ¹ -Number + -Kind Codes (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines Where Relevant Figures Appear	Translation Yes No

OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER'S INITIALS	CITE NO.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
A7		Office Action for Corresponding Korean Patent Application 10-2004-7000337 dated August 31, 2005

EXAMINER

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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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						Yes	No
AT		JP 6-177744 (w/ English Abstract) & EP 600734 A1, US 5,387,828 A	08/24/1994	NEC CORP.			
		JP 6-204850 (w/ English Abstract)	07/22/1994	OKI ELECTRIC IND. CO., LTD.			
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		JP 1-253309	No date	COPY NOT ENCLOSED.			

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